

<b>Notice of References Cited</b>	Application/Control No. 10/071,116	Applicant(s)/Patent Under Reexamination DE VERTEUIL, ANDRE LAURE	
	Examiner Julio R Perez	Art Unit 2681	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,859,173 B2	02-2005	Spilker et al.	342/464
	B	US-6,324,404 B1	11-2001	Dennison et al.	455/456.1
	C	US-2002/0090957 A1	07-2002	Harris, Robert	455/456
	D	US-5,724,660 A	03-1998	Kauser et al.	455/456.2
	E	US-2003/0157939 A1	08-2003	Wang et al.	455/446
	F	US-6,212,392 B1	04-2001	Fitch et al.	455/456.2
	G	US-2003/0148774 A1	08-2003	Naghian et al.	455/456
	H	US-2002/0123354 A1	09-2002	Nowak, Steven P.	455/456
	I	US-6,246,884 B1	06-2001	Karmi et al.	455/521
	J	US-5,272,483 A	12-1993	Kato, Takahiro	342/357.14
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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